Search Notes

Application/Control No.

Applicant(s)/Patent under Reexamination

TOYAMA, KENTARO
Art Unit

09/683,448 Examiner

2623

Ashutosh Upreti

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| SEARCHED | | | | | |
| Class | Subclass | Date | Examiner | | |
| 382 | 103 | 02/15/05 | A·U. | | |
| 348 | 14.01 | 02/16/05 | A·u. | | |
| 348 | 14.16 | 02/16/05 | A.U. | | |
| 382 | ALL | 02/16/05 | A.U. | | |
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| INTERFERENCE SEARCHED | | | | | |
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| Class | Subclass | Date | Examiner | | |
| 385 | 103,118 | 02/15/05 | A·u. | | |
| 348 | 14.01,14.08, | 02/16/05 | A.U. | | |
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| SEARCH NOTES | | | | |
|--|----------|------|--|--|
| (INCLUDING SEARCH | DATE | EXMR | | |
| Consulted Jon Chang 382/103,118 + To see search notes history | 02/14/05 | A·u. | | |
| Inventorship Search | 02/14/05 | А·Ц, | | |
| Consulted Jon Chang All of 382 | 02/16/05 | A·U. | | |
| IEEE (face or facial) and page and head | 02/17/05 | A.U. | | |
| Jon searched in 382 \$348 see search history | 02/17/05 | A.U. | | |
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